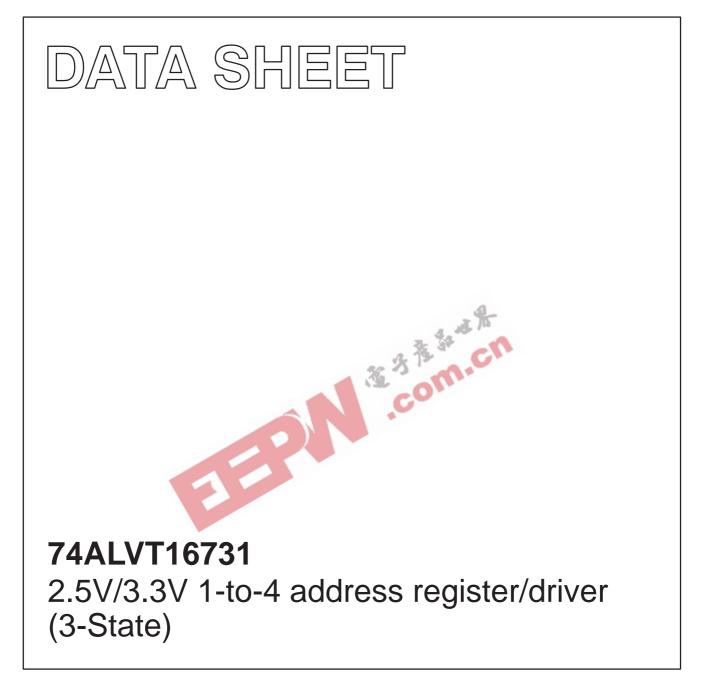
INTEGRATED CIRCUITS



Product specification

1999 Mar 23

IC24 Data Handbook



74ALVT16731

FEATURES

- 5V I/O Compatible
- 3-State outputs
- Output capability: +64 mA/-32 mA
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up reset
- Power-up 3-State
- Positive edge triggered registers
- Latch-up protection exceeds 500 mA per JEDEC JC40.2 Std 17
- ESD protection exceeds 2000 V per MIL STD 883 Method 3015 and 200 V per machine model
- Bus hold data inputs eliminate the need for external pull-up resistors to hold unused inputs

QUICK REFERENCE DATA

DESCRIPTION

The 74ALVT16731 is a high-performance BiCMOS product designed for V_{CC} operation at 2.5V to 3.3V with I/O compatibility up to 5V.

This device is a 1-to-4 address register/driver featuring non-inverting 3-State outputs. The state of the outputs are controlled by two enable inputs (OE1 and OE2). Each enable input controls the state of two of the four common outputs for each input. When an OEn input is a logic High, the respective outputs will be in the high impedance state. When an OEn input is a logic Low, the respective outputs are active. The device can be configured for a transparent mode from input to output or a register mode by the SEL input. When SEL is a logic High the device is configured for register mode and when SEL is a logic Low it is configured for register mode. While in the register mode the output follows the input on the rising edge of the CLK input. The function of the data registers is not effected by either SEL or OEn.



| SYMBOL | DADAMETED | CONDITIONS | TYPI | UNIT | |
|--------------------------------------|---------------------------------|---|------------|------------|------|
| STMBOL | PARAMETER | PARAMETER $T_{amb} = 25^{\circ}C; GND = 0V$ | | 3.3V | UNIT |
| t _{PLH} t _{PHL} | Propagation delay nAx to nYx | C _L = 50pF | 3.1 2.3 | 2.1 1.8 | ns |
| C _{IN} | Input capacitance | $V_I = 0V \text{ or } V_{CC}$ | 4 | 4 | pF |
| C _{OUT} | Output capacitance | Outputs disabled; $V_0 = 0V$ or V_{CC} | 9 | 9 | pF |
| I _{CCZ} | Total supply current | Outputs disabled | 40 | 70 | μΑ |

ORDERING INFORMATION

| PACKAGES | TEMPERATURE RANGE | OUTSIDE NORTH AMERICA | NORTH AMERICA | DWG NUMBER |
|------------------------------|-------------------|-----------------------|---------------|------------|
| 56-Pin Plastic SSOP Type III | –40°C to +85°C | 74ALVT16731 DL | AV16731 DL | SOT371-1 |
| 56-Pin Plastic TSSOP Type II | –40°C to +85°C | 74ALVT16731 DGG | AV16731 DGG | SOT364-1 |

PIN DESCRIPTION

| PIN NUMBER | SYMBOL | NAME AND FUNCTION |
|---|-----------------------------------|---------------------------------------|
| 1, 4, 19, 25, 28, 32, 38, 41, 47, 53 | GND | Ground |
| 5, 6, 23, 24, 30, 31, 36, 37, 42, 43, 48, 49, 54, 55 | 1Y _n , 2Y _n | Output, controlled by OE1 |
| 2, 3, 20, 21, 26, 27, 33, 34, 39, 40, 45, 46, 51, 52 | 3Y _n ,4Y _n | Output, controlled by OE2 |
| 7, 22, 29, 35, 44, 50, 56 | V _{CC} | Positive power supply |
| 8, 9, 10, 15, 16, 17, 18 | A _n | Data inputs |
| 14 | SEL | Select input, controls mode of device |
| 11 | CLK | Clock input |
| 12, 13 | OE _n | Output enable |

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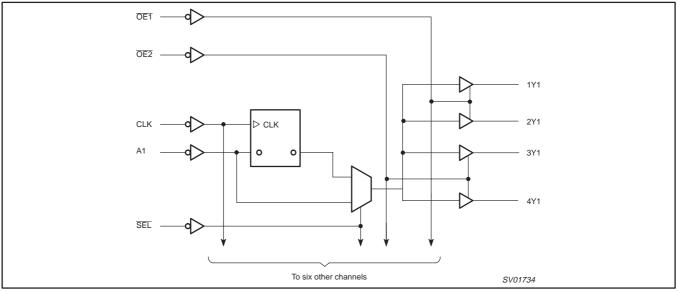
PIN CONFIGURATION



FUNCTION TABLE

| | INPUTS | | | | |
|----|--------|-----|---|---|--|
| ŌE | SEL | CLK | A | Y | |
| Н | Х | Х | Х | Z | |
| L | Н | Х | L | L | |
| L | Н | Х | Н | Н | |
| L | L | Ť | L | L | |
| L | L | Ť | Н | H | |

LOGIC DIAGRAM



74ALVT16731

ABSOLUTE MAXIMUM RATINGS^{1, 2}

| SYMBOL | PARAMETER | CONDITIONS | RATING | UNIT |
|------------------|--------------------------------|-----------------------------|--------------|------|
| V _{CC} | DC supply voltage | | -0.5 to +4.6 | V |
| I _{IK} | DC input diode current | V _I < 0 | -50 | mA |
| VI | DC input voltage ³ | | -0.5 to +7.0 | V |
| I _{ОК} | DC output diode current | V _O < 0 | -50 | mA |
| V _{OUT} | DC output voltage ³ | Output in Off or High state | -0.5 to +7.0 | V |
| laum. | DC output current | Output in Low state | 128 | mA |
| lout | | Output in High state | -64 | |
| T _{stg} | Storage temperature range | | -65 to +150 | °C |

NOTES:

Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction the performance detributed between the temperature of the integrated circuit at a state of the

The performance capability of a high performance integrated circuit in conjunction with its integrated circuit should not exceed 150°C.
The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

15.1

RECOMMENDED OPERATING CONDITIONS

| SYMBOL | PARAMETER | | 2.5V RANGE LIMITS | | 3.3V RANGE LIMITS | | UNIT |
|-----------------------|--|--|-------------------|-----|-------------------|-----|------|
| STWBOL | | | MIN | MAX | MIN | MAX | UNIT |
| V _{CC} | DC supply voltage | | 2.3 | 2.7 | 3.0 | 3.6 | V |
| VI | Input voltage | | 0 | 5.5 | 0 | 5.5 | V |
| V _{IH} | High-level input voltage | | 1.7 | | 2.0 | | V |
| V _{IL} | Input voltage | | | 0.7 | | 0.8 | V |
| I _{ОН} | High-level output current | | | -8 | | -32 | mA |
| 1 | Low-level output current | | | 8 | | 32 | mA |
| IOL | Low-level output current; current duty cycle \leq 50%; f \geq 1kHz | | | 24 | | 64 | IIIA |
| $\Delta t / \Delta v$ | Input transition rise or fall rate; Outputs enabled | | | 10 | | 10 | ns/V |
| T _{amb} | Operating free-air temperature range | | -40 | +85 | -40 | +85 | °C |

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| | | | | L | IMITS | | |
|--------------------|--|--|---------------------------------------|-----------------------|------------------|------|------|
| SYMBOL | PARAMETER | TEST CONDITIONS | | Temp = -40°C to +85°C | | | UNIT |
| | | | | MIN | TYP ¹ | MAX | |
| V _{IK} | Input clamp voltage | $V_{CC} = 3.0V; I_{IK} = -18mA$ | | | -0.85 | -1.2 | V |
| V | High-level output voltage | V _{CC} = 3.0 to 3.6V; I _{OH} = -100μA | | V _{CC} -0.2 | V _{CC} | | V |
| V _{OH} | High-level output voltage | $V_{CC} = 3.0V; I_{OH} = -32mA$ | | 2.0 | 2.3 | | v |
| | | $V_{CC} = 3.0V; I_{OL} = 100\mu A$ | | | 0.07 | 0.2 | |
| V _{OL} | Low-level output voltage | V _{CC} = 3.0V; I _{OL} = 16mA | | | 0.25 | 0.4 | v |
| V OL | Low-level output voltage | V _{CC} = 3.0V; I _{OL} = 32mA | | | 0.3 | 0.5 | v |
| | | $V_{CC} = 3.0V; I_{OL} = 64mA$ | | | 0.4 | 0.55 | |
| V _{RST} | Power-up output low voltage ⁶ | V_{CC} = 3.6V; I_{O} = 1mA; V_{I} = V_{CC} or GND | | | | 0.55 | V |
| | | $V_{CC} = 3.6V; V_I = V_{CC} \text{ or GND}$ Cont | trol pins | | 0.1 | ±1 | |
| | | $V_{CC} = 0 \text{ or } 3.6 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$ | | | 0.1 | 10 | |
| ¹ 1 | Input leakage current | $V_{CC} = 3.6V; V_{I} = V_{CC}$ | S.A. | | 0.5 | 1 | μA |
| | | $V_{CC} = 3.6V; V_{I} = 0$ | a pi ns ⁴ | | 0.1 | -5 | |
| I _{OFF} | Off current | $V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$ | | | 0.1 | ±100 | μA |
| | Bus Hold current | V _{CC} = 3V; V _I = 0.8V | C | 75 | 130 | | |
| I _{HOLD} | Data inputs ⁷ | $V_{CC} = 3V; V_1 = 2.0V$ | · · · · · · · · · · · · · · · · · · · | -75 | -225 | | μA |
| | Data inputs | $V_{CC} = 0V \text{ to } 3.6V; V_{CC} = 3.6V$ | | ±500 | | | |
| I _{EX} | Current into an output in the High state when $V_O > V_{CC}$ | V _O = 5.5V; V _{CC} = 3.0V | | | 10 | 125 | μΑ |
| I _{PU/PD} | Power up/down 3-State output current ³ | $V_{CC} \le 1.2V$; $V_O = 0.5V$ to V_{CC} ; $V_I = GND$ or V_{CC} OE/OE = Don't care | с | | 1 | ±100 | μΑ |
| I _{OZH} | 3-State output High current | $V_{CC} = 3.6$ V; $V_{O} = 3.0$ V; $V_{I} = V_{IL}$ or V_{IH} | | | 0.5 | 5 | μΑ |
| I _{OZL} | 3-State output Low current | $V_{CC} = 3.6V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$ | | | 0.5 | -5 | μΑ |
| I _{CCH} | | V_{CC} = 3.6V; Outputs High, V _I = GND or V _{CC} , I _O | = 0 | | 0.05 | 0.1 | |
| I _{CCL} | Quiescent supply current | V_{CC} = 3.6V; Outputs Low, V_I = GND or V_{CC} , I_O = | | | 7.0 | 9.0 | mA |
| I _{CCZ} | | V_{CC} = 3.6V; Outputs Disabled; V_{I} = GND or V_{CC} | $_{\rm C, I_{\rm O}} = 0^5$ | | 0.06 | 0.1 | |
| ΔI _{CC} | Additional supply current per input pin ² | V_{CC} = 3V to 3.6V; One input at V _{CC} -0.6V, Other inputs at V _{CC} or GND | | | 0.04 | 0.4 | mA |

DC ELECTRICAL CHARACTERISTICS (3.3V ±0.3V RANGE)

NOTES:

1. All typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25^{\circ}C$. 2. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND 3. This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From $V_{CC} = 1.2V$ to $V_{CC} = 3.3V \pm 0.3V$ a transition time of 100µsec is permitted. This parameter is valid for Tamb = 25°C only.

4. Unused pins at V_{CC} or GND. 5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground. 6. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power. 7. This is the bus hold overdrive current required to force the input to the opposite logic state.

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AC CHARACTERISTICS (3.3V ±0.3V RANGE)

GND = 0V; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to +85°C.

| | | | | UNIT | | |
|--------------------------------------|--|----------|------------|------------------|------------|----|
| SYMBOL | PARAMETER | WAVEFORM | Vc | | | |
| | | | MIN | TYP ¹ | MAX | |
| t _{PLH} t _{PHL} | Propagation delay nAx to nYx | 1 | 1.0 1.0 | 2.1 1.8 | 4.0 3.4 | ns |
| t _{PLH} t _{PHL} | Propagation delay CLK to nYx | 3 | 1.5 1.5 | 2.8 2.7 | 4.7 4.4 | ns |
| t _{PLH} t _{PHL} | Propagation delay SEL to nYx | 1 | 1.5 1.0 | 3.5 2.7 | 5.4 4.4 | ns |
| t _{PZH} t _{PZL} | Output enable time to High and Low level | 2 | 1.0 1.0 | 3.3 2.3 | 5.2 4.1 | ns |
| t _{PHZ} t _{PLZ} | Output disable time from High and Low Level | 2 | 1.5 1.5 | 3.7 3.0 | 5.6 4.5 | ns |

| | les are at V _{CC} = 3.3V and T _{amb} = 25°C. EQUIREMENTS (3.3V \pm 0.3V RANG | SE) C to +85°C. | A The | | | |
|----------------------|---|---------------------------|-------|------------------------------|-----------------------------|------|
| $ND = 0V; t_R = t_F$ | $c = 2.5$ ns; $C_L = 50$ pF, $\dot{R}_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ | - CON | | LIM | - | |
| SYMBOL | PARAMETER | WAVEFORM | | V _{CC} = 3.3 MIN | V ±0.3V TYP ¹ | UNIT |
| ts(H) ts(L) | Setup time, High or Low Ax to CLK | 4 | | 1.5 1.5 | 1.0 1.0 | ns |
| th(H) th(L) | Hold time, High or Low Ax to CLK | 4 | | 0 0 | -0.9 -0.9 | ns |
| tw(H) tw(L) | Pulse width, High or Low CLK | 3 | | 1.5 1.5 | | ns |

NOTE:

1. All typical values are at $V_{CC} = 3.3V$ and $T_{amb} = 25^{\circ}C$.

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| | | | | | LIMITS | | |
|--------------------|--|---|--|----------------------|------------------|------|----|
| SYMBOL | PARAMETER | TEST CONDITIONS | | Temp = -40°C to +85° | | | |
| | | | | MIN | TYP ¹ | MAX | |
| V _{IK} | Input clamp voltage | $V_{CC} = 2.3V; I_{IK} = -18mA$ | | | -0.85 | -1.2 | V |
| V _{ОН} | High-level output voltage | $V_{CC} = 2.3$ to 3.6V; $I_{OH} = -100\mu A$ | | V _{CC} -0.2 | V _{CC} | | V |
| VОН | Tightever output voltage | $V_{CC} = 2.3V; I_{OH} = -8mA$ | | 1.8 | 2.1 | | v |
| | | $V_{CC} = 2.3V; I_{OL} = 100\mu A$ | | | 0.07 | 0.2 | |
| V _{OL} | Low-level output voltage | $V_{CC} = 2.3V; I_{OL} = 24mA$ | | | 0.3 | 0.5 | V |
| | | $V_{CC} = 2.3V; I_{OL} = 8mA$ | | | | 0.4 | |
| V _{RST} | Power-up output low voltage ⁷ | V_{CC} = 2.7V; I_{O} = 1mA; V_{I} = V_{CC} or GND | | | | 0.55 | V |
| | | $V_{CC} = 2.7 V$; $V_I = V_{CC}$ or GND | Control pins | | 0.1 | ±1 | |
| | Input leakage current | V _{CC} = 0 or 2.7V; V _I = 5.5V | | | 0.1 10 | 10 | μA |
| łı | input leakage current | $V_{CC} = 2.7V; V_{I} = V_{CC}$ | Data pins4 | | 0.1 | 10 | μΑ |
| | | $V_{CC} = 2.7V; V_{I} = 0$ | 1000 | | 0.1 | -5 | |
| I _{OFF} | Off current | $V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$ | 40 10 | | 0.1 | ±100 | μA |
| I _{HOLD} | Bus Hold current | V _{CC} = 2.3V; V _I = 0.7V | 37 | | 90 | | μΑ |
| HOLD | Data inputs ⁶ | V _{CC} = 2.3V; V _I = 1.7V | - | | -10 | | μA |
| I _{EX} | Current into an output in the High state when $V_O > V_{CC}$ | V _O = 5.5V; V _{CC} = 2.3V | | | 10 | 125 | μA |
| I _{PU/PD} | Power up/down 3-State output current ³ | $V_{CC} \le 1.2V$; $V_{O} = 0.5V$ to V_{CC} ; $V_{I} = GND$ OE/OE = Don't care | or V _{CC} | | 1 | ±100 | μA |
| I _{OZH} | 3-State output High current | $V_{CC} = 2.7V; V_{O} = 2.3V; V_{I} = V_{IL} \text{ or } V_{IH}$ | | | 0.5 | 5 | μA |
| I _{OZL} | 3-State output Low current | $V_{CC} = 2.7V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$ | $V_{CC} = 2.7V; V_{O} = 0.5V; V_{I} = V_{IL} \text{ or } V_{IH}$ | | 0.5 | -5 | μA |
| I _{CCH} | | $V_{CC} = 2.7V$; Outputs High, V _I = GND or V | √ _{CC,} I _{O =} 0 | | 0.04 | 0.1 | |
| I _{CCL} | Quiescent supply current | $V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_O = 0$ | | | 5.0 | 7.0 | mA |
| I _{CCZ} | | V_{CC} = 2.7V; Outputs Disabled; V _I = GND |) or $V_{CC, I_{O}} = 0^5$ | | 0.04 | 0.1 | |
| ΔI_{CC} | Additional supply current per input pin ² | V_{CC} = 2.3V to 2.7V; One input at V _{CC} -0. Other inputs at V _{CC} or GND | 6V, | | 0.04 | 0.4 | mA |

DC ELECTRICAL CHARACTERISTICS (2.5V ± 0.2V RANGE)

NOTES:

1. All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.

2. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND

3. This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From V_{CC} = 1.2V to V_{CC} = 2.5V \pm 0.2V a transition time of 100µsec is permitted. This parameter is valid for T_{amb} = 25°C only.

4. Unused pins at V_{CC} or GND. 5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.

6. Not guaranteed.

7. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.

AC CHARACTERISTICS (2.5V ± 0.2V RANGE)

GND = 0V; $t_R = t_F = 2.5$ ns; $C_L = 50$ pF; $R_L = 500\Omega$; $T_{amb} = -40^{\circ}$ C to +85°C.

| | | | | UNIT | | |
|--------------------------------------|--|----------|------------|------------------|------------|----|
| SYMBOL | PARAMETER | WAVEFORM | Vc | | | |
| | | | MIN | TYP ¹ | MAX | |
| t _{PLH} t _{PHL} | Propagation delay nAx to nYx | 1 | 1.0 1.0 | 3.1 2.3 | 5.5 4.2 | ns |
| t _{PLH} t _{PHL} | Propagation delay CLK to nYx | 3 | 2.2 2.2 | 4.0 3.5 | 6.6 6.0 | ns |
| t _{PLH} t _{PHL} | Propagation delay SEL to nYx | 1 | 1.5 1.0 | 4.8 3.3 | 7.9 6.1 | ns |
| t _{PZH} t _{PZL} | Output enable time to High and Low level | 2 | 2.0 2.0 | 4.7 3.2 | 7.7 5.6 | ns |
| t _{PHZ} t _{PLZ} | Output disable time from High and Low Level | 2 | 1.5 1.5 | 4.5 3.7 | 6.9 5.9 | ns |

NOTE:

74ALVT16731

1. All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.

AC SETUP REQUIREMENTS (2.5V ± 0.2V RANGE)

GND = 0V; $t_R = t_F = 2.5ns$; $C_L = 50pF$, $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to +85°C.

| | | | LIM | | |
|------------------|--------------------------------------|----------|----------------------|------------------|----|
| SYMBOL PARAMETER | | WAVEFORM | V _{CC} = 2. | UNIT | |
| | | | MIN | TYP ¹ | |
| ts(H) ts(L) | Setup time, High or Low Ax to CLK | 4 | 2.4 2.3 | 0.9 0.8 | ns |
| th(H) th(L) | Hold time, High or Low Ax to CLK | 4 | 0 0 | -0.7 -0.6 | ns |
| tw(H) tw(L) | Pulse width, High or Low CLK | 3 | 1.5 1.5 | | ns |

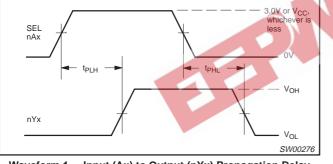
NOTE:

1. All typical values are at V_{CC} = 2.5V and T_{amb} = 25°C.

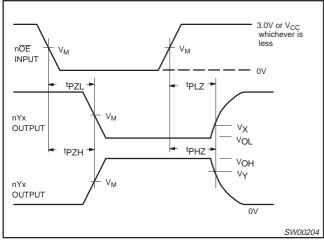
AC WAVEFORMS

NOTES:

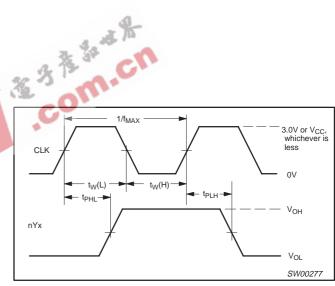
- 1. $V_M = 1.5V$ at $V_{CC} \ge 3.0V$, $V_M = V_{CC}/2$ at $V_{CC} \le 2.7V$ 2. $V_X = V_{OL} + 0.3V$ at $V_{CC} \ge 3.0V$, $V_X = V_{OL} + 0.150V$ at $V_{CC} \le 2.7V$ 3. $V_Y = V_{OH} 0.3V$ at $V_{CC} \ge 3.0V$, $V_Y = V_{OH} 0.150V$ at $V_{CC} \le 2.7V$



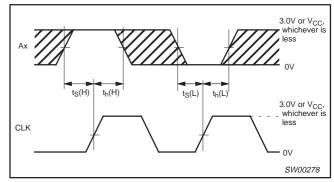
Waveform 1. Input (Ax) to Output (nYx) Propagation Delay, transparent mode. SEL to Output (nYx) Propagation Delay



Waveform 2. 3-State Output Enable and Disable Times



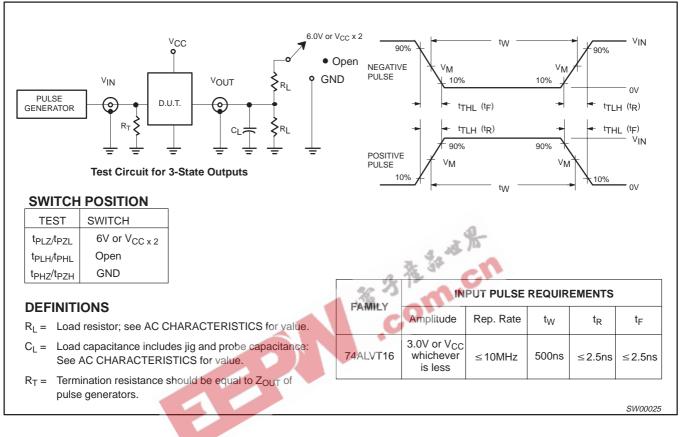
Waveform 3. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency

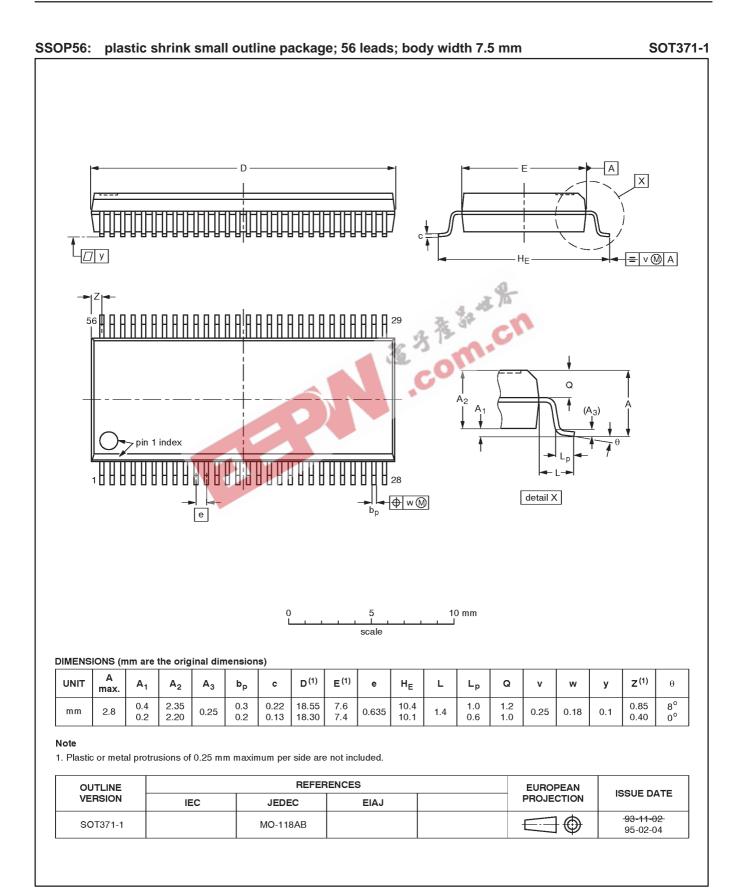


Waveform 4. Data Setup and Hold Times

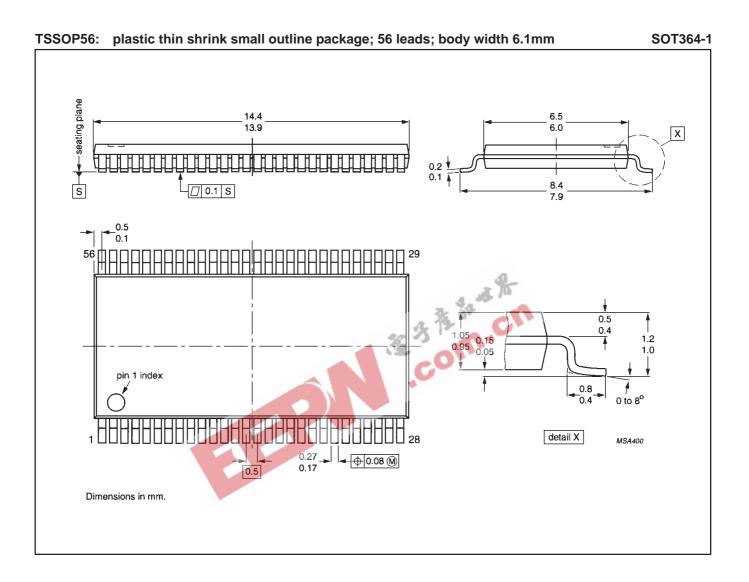
74ALVT16731

TEST CIRCUIT AND WAVEFORMS





74ALVT16731



74ALVT16731



| DEFINITIONS | | |
|---------------------------|------------------------|--|
| Data Sheet Identification | Product Status | Definition |
| Objective Specification | Formative or in Design | This data sheet contains the design target or goal specifications for product development. Specifications may change in any manner without notice. |
| Preliminary Specification | Preproduction Product | This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product. |
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